

# **The Silicon Electron Multiplier**

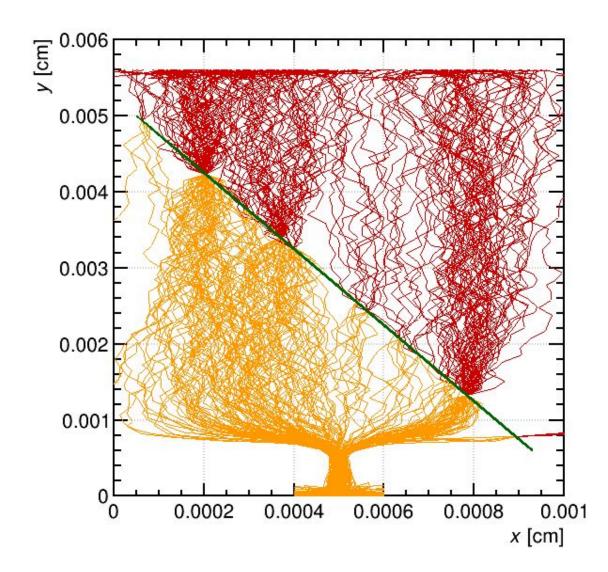
Victor Coco<sup>1</sup>, Vagelis Gkougkousis<sup>1</sup>, Marius Mæhlum Halvorsen<sup>1,2</sup>

The 39<sup>th</sup> RD50, Valencia, November 19<sup>th</sup> 2021

<sup>1</sup>CERN, <sup>2</sup>University of Oslo

#### **Overview**

- Motivation, framework and introduction
- Working principles
- Plans of fabrication
- Outlook





#### **Motivation**

| [fineprint in CERN-OPEN-2018-006]                | HL-LHC             | SPS              | FCC-ee           | FCC-hh           |
|--|--------------------|------------------|------------------|------------------|
| Fluence [n <sub>eq</sub> /cm <sup>2</sup> /y]    | 5x10 <sup>16</sup> | 10 <sup>17</sup> | 10 <sup>10</sup> | 10 <sup>17</sup> |
| Max Hit rate [cm <sup>-2</sup> s <sup>-1</sup> ] | 2-4G               | 8G               | 20M              | 20G              |
| Material budget per layer [X <sub>0</sub> ]      | 0.1-2%             | 2%               | 0.3%             | 1%               |
| Pixel size [µm <sup>2</sup> ]<br>inner trackers  | 50x50              | 50x50            | 25x25            | 25x25            |
| Temporal hit resolution [ps]<br>inner trackers   | ~50                | ~40              | -                | ~10              |

#### Our approach

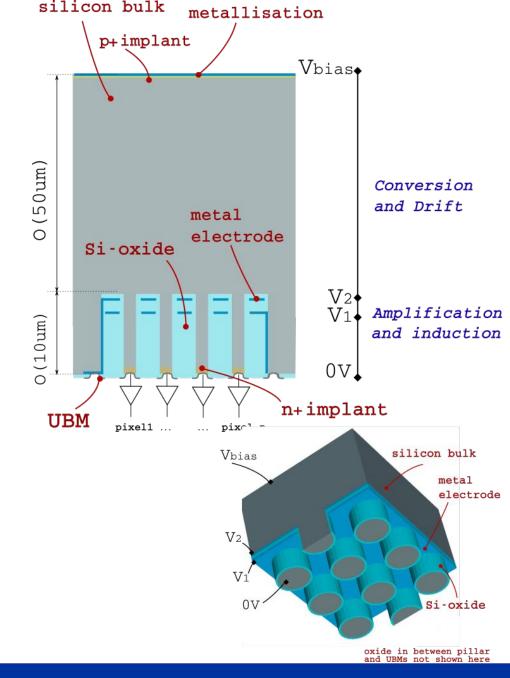
- Future inner tracker detectors will requite
  - Time resolution between 10 and 50ps -
  - Pixel pitch down to 25µm
  - Radiation hardness up to 10<sup>17</sup>n<sub>eq</sub>

- Gain
- Small thickness, doping independent gain



#### **Motivation**

- Make a radiation hard sensor with internal gain
  - Avoid doping dependent gain regions'
- Idea: Generate high electric field regions by applying a potential difference to a set of electrodes
- Inversely etch (or grow) pillar structures
  - Silicon, diamond, SiC ...
  - One or more layer of electrode grids
- Electrons drifting in the "amplification and induction" region multiply and enhance the signal

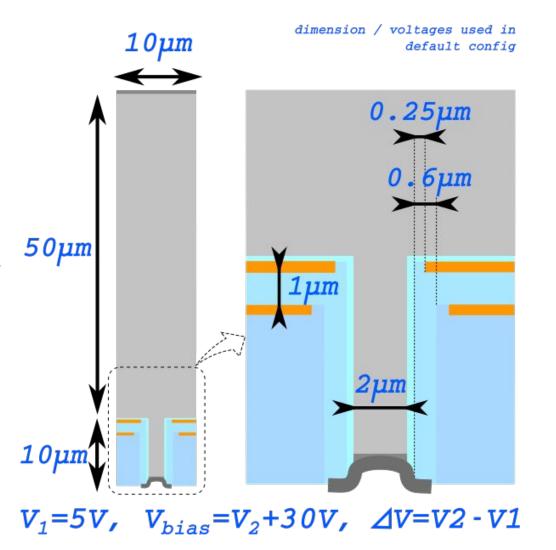




### Geometry

- First consider DRIE process
  - Etching of pillars and consecutive deposition of metal and oxide
- Process related constraints:
  - Guard and height of pillar
  - Sufficient guard around pillars to not get metal on pillar walls
- Impact on geometry
  - Pillar height 4-15µm,
  - Pillar width 1-4µm
  - Inter pillar distance more than 6µm

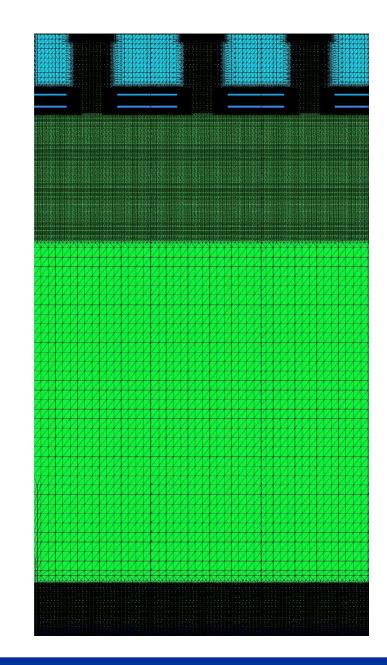
- Other fabrication techniques have different geometrical constraints





## **Synopsys TCAD simulations**

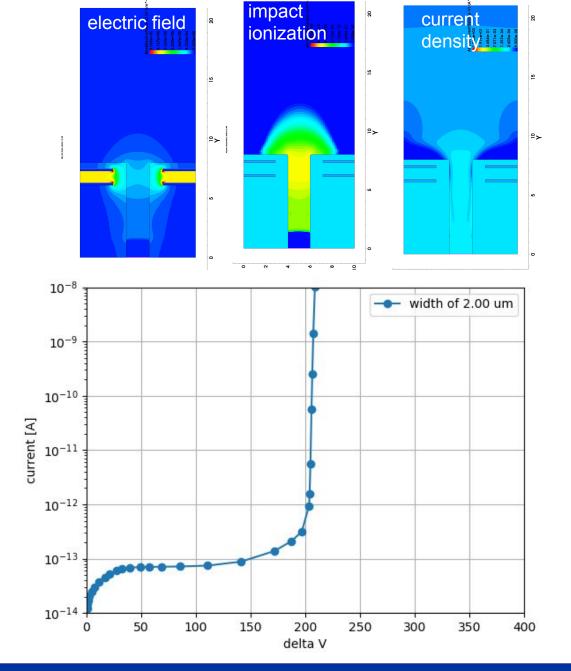
- Synopsys TCAD
  - Version Q-2019.12
  - Version Q-2021.06
- Impact ionization model: vanOverstraeten
  - Tested university of Bologna model
- Mobility model: Canali
- Solver: PARDISO
- Recombination: Shockley-Read-Hall
- Transient model: Heavylon
- Band gap model: Slotboom





### **Quasi-stationary simulations**

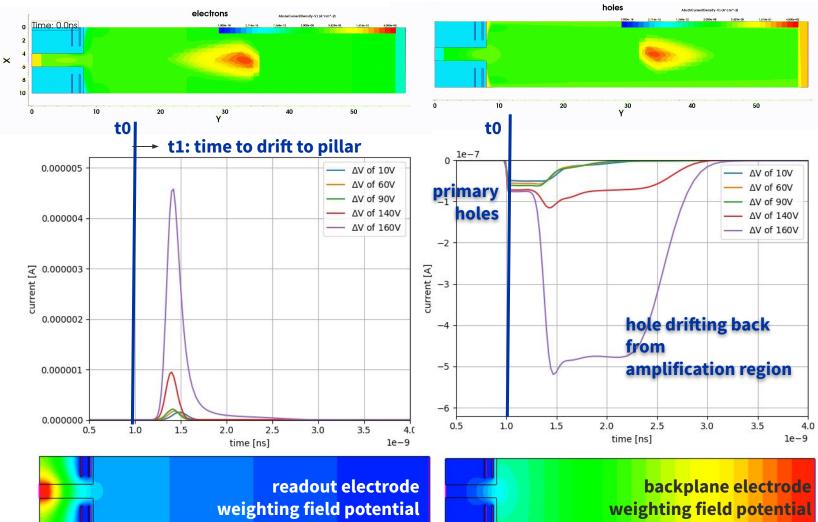
- Evaluate electric field and leakage current
  - Breakdown position depends on biasing configuration
- Pillar and bulk depletes
  - Pillar density
- High electric field in the pillars can be reached
  - Above 15V/µm





# Signal simulations and charge multiplication

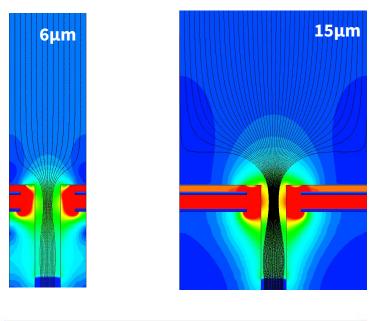
- Charge cloud deposited in bulk center
- Charges drift and get multiplied in pillars.
- Gain=  $Q_{collected}/Q_{injected}$ Gain achieved for  $\Delta V > 100V$ 
  - above 10 has been simulated
- Weighting field of readout electrode is concentrated in the pillar
  - Shielded by multiplication electrode
- Weighting field of backside electrode
  - "Pad like"

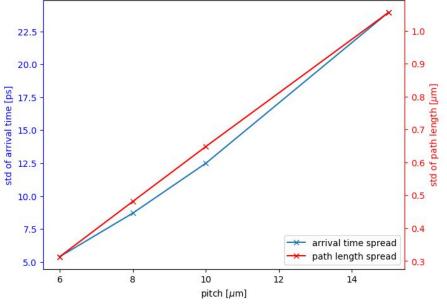




#### **Optimisation** Pillar pitch and timing performances

- Arrival time distribution at the gain layer will play a large role on the final time resolution
  See [Riegler,Windischhofer; NIM A (2021) 165265]
- Inhomogeneity in path
  - Can be reduced by reducing the inter-pillar distance
  - Down to 5ps for 6um
- Can expect similar time resolution as LGADs, to be confirmed with full MIP simulations

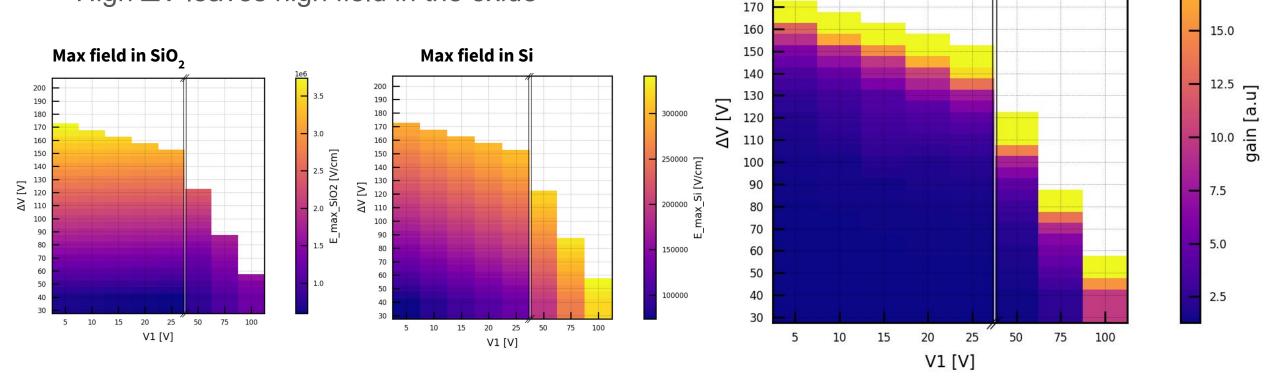






### **Optimisation**

- Interplay between  $V_1$  and  $\Delta V$  can be optimised
  - freedom in choice of operation settings
- High  $V_1$  leaves high field in silicon
- High  $\Delta V$  leaves high field in the oxide





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190

180

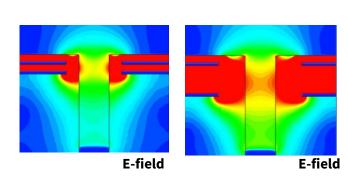
20.0

17.5

#### **Optimisation** Electrode geometry

- Electrode geometries and pillar height
  - Retraction of the shallower electrode allow to better fill the pillar with high field
  - Similar effect to rising V<sub>1</sub>
- Single electrode configuration
  - Simpler but higher field in the silicon
  - Different breakdown location
- Larger inter-electrode distance
  - Better spreading of the field
  - Less localised high field values

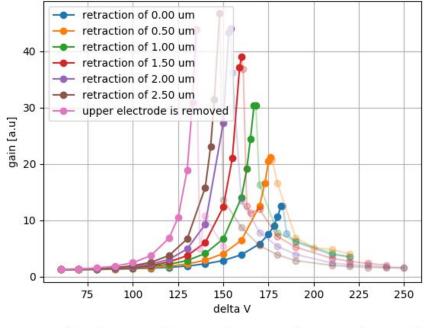
Several degrees of freedom to cope with production process constraints

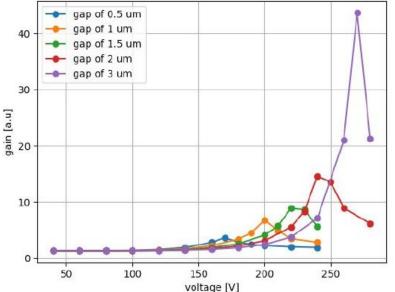


retraction of 0µm

retraction of 0µm

current density







The 39th RD50, Valencia November 19th 2021 retraction of 2.5µm

upper electrode removed

current density

#### **Possible production processes**

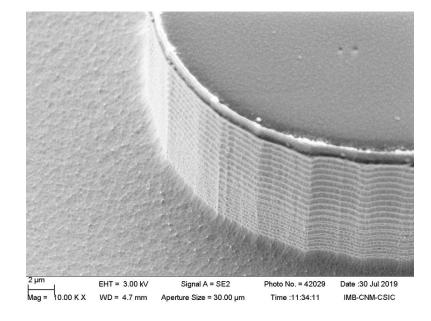
#### **DRIE** based

- Discussions about the process and its constraints with LeTI and CNM
- Now: evaluate what topology that can really be achieved
  - Electrode/wall guard, thickness of oxide, corner shapes...
- Next: electrical properties?
  - SiO<sub>2</sub>/Si interface, scalloping, ...
- Homogeneity of the production?
- Performances

#### To be investigated in 2022

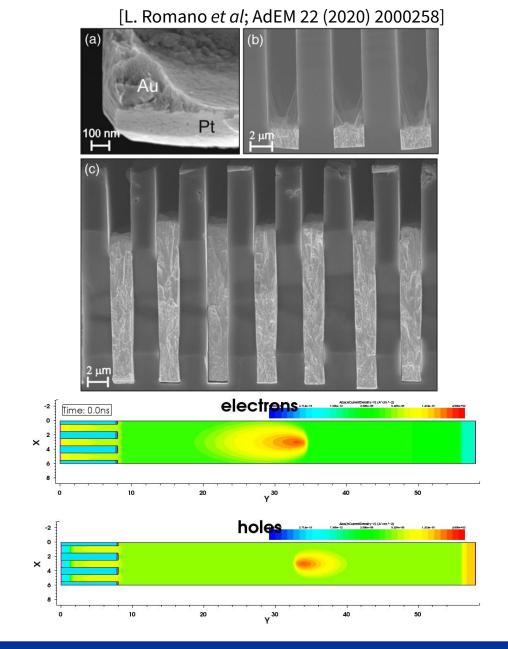


#### [courtesy of CNM]



### **Metal Assisted Chemical Etching**

- Discussions with PSI
- MacEtch Process
  - Metal mask used as a catalyst for etching.
  - Electroplating with gold
  - Electrode directly on silicon
- Less "production ready"
- More appropriate for single electrode structure
- Denser pillars
- No more constraints on the guard
- Could be a simpler processing technique
- Simulations started

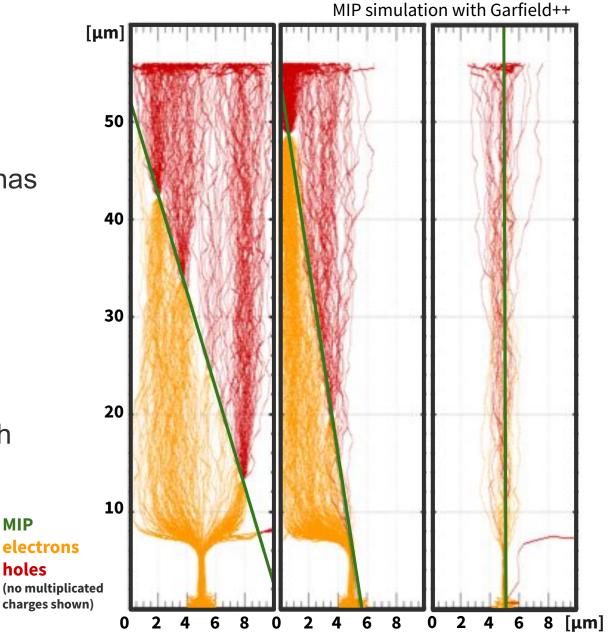




## **Summary and Outlook**

- A new solid state radiation detector concept has \_ been presented.
  - Small pitch -
  - Expected time resolution similar to LGADs \_
  - Gain is not doping dependent -

- Next steps
  - finish simulations full MIP simulations with \_ Garfield++
  - preparation to produce a demonstrator





MIP



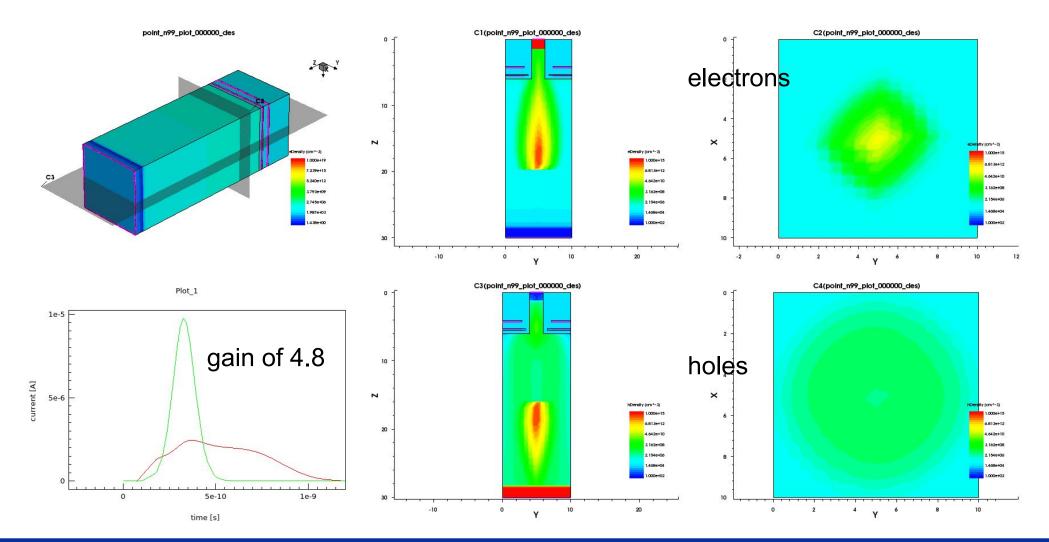
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#### **3D simulations**



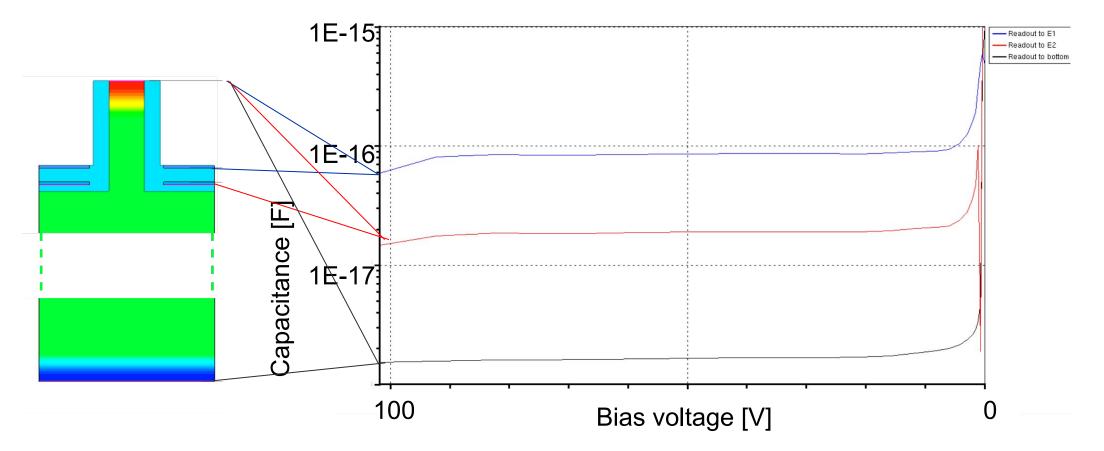


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# Simulation of one unit cell (no inter-pixel capacitance)





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